

Single N-channel MOSFET

ELM14354AA-N

■ General description

ELM14354AA-N uses advanced trench technology to provide excellent $R_{ds(on)}$, low gate charge and low gate resistance.

■ Features

- $V_{ds}=30V$
- $I_d=23A$ ($V_{gs}=10V$)
- $R_{ds(on)} < 3.7m\Omega$ ($V_{gs}=10V$)
- $R_{ds(on)} < 5.3m\Omega$ ($V_{gs}=4.5V$)

■ Maximum absolute ratings

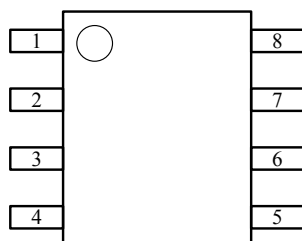
Parameter	Symbol	Limit	Unit	Note	
Drain-source voltage	V_{ds}	30	V		
Gate-source voltage	V_{gs}	± 20	V		
Continuous drain current	I_d	$T_a=25^\circ C$	23	A	
		$T_a=100^\circ C$	14		
Pulsed drain current	I_{dm}	174	A	3	
Avalanche current	I_{as}	37	A	3	
Repetitive avalanche energy	$L=0.1mH$	E_{as}	68	mJ	3
V_{ds} Spike	100ns	V_{spike}	36	V	
Power dissipation	P_d	$T_a=25^\circ C$	3.1	W	2
		$T_a=100^\circ C$	1.2		
Junction and storage temperature range	T_j, T_{stg}	-55 to 150	$^\circ C$		

■ Thermal characteristics

Parameter		Symbol	Typ.	Max.	Unit	Note
Maximum junction-to-ambient	$t \leq 10s$	$R_{\theta ja}$	31	40	$^\circ C/W$	1
Maximum junction-to-ambient	Steady-state		59	75	$^\circ C/W$	1, 4
Maximum junction-to-lead	Steady-state	$R_{\theta jl}$	16	24	$^\circ C/W$	

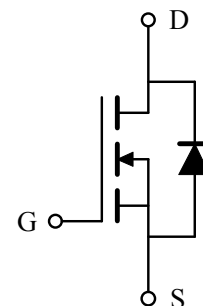
■ Pin configuration

SOP-8(TOP VIEW)



Pin No.	Pin name
1	SOURCE
2	SOURCE
3	SOURCE
4	GATE
5	DRAIN
6	DRAIN
7	DRAIN
8	DRAIN

■ Circuit



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■Electrical characteristics

Ta=25°C

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
STATIC PARAMETERS						
Drain-source breakdown voltage	BV _{dss}	I _d =250μA, V _{gs} =0V	30			V
Zero gate voltage drain current	I _{dss}	V _{ds} =30V, V _{gs} =0V T _j =55°C			1	μA
					5	
Gate-body leakage current	I _{gss}	V _{ds} =0V, V _{gs} =±20V			100	nA
Gate threshold voltage	V _{gs(th)}	V _{ds} =V _{gs} , I _d =250μA	1.2	1.8	2.2	V
Static drain-source on-resistance	R _{ds(on)}	V _{gs} =10V, I _d =20A T _j =125°C		3.0	3.7	mΩ
				4.1	5.0	
		V _{gs} =4.5V, I _d =20A		4.1	5.3	mΩ
Forward transconductance	G _{fs}	V _{ds} =5V, I _d =20A		105		S
Diode forward voltage	V _{sd}	I _s =1A, V _{gs} =0V		0.7	1.0	V
Max. body-diode continuous current	I _s				4	A
DYNAMIC PARAMETERS						
Input capacitance	C _{iss}			2010		pF
Output capacitance	C _{oss}	V _{gs} =0V, V _{ds} =15V, f=1MHz		898		pF
Reverse transfer capacitance	C _{rss}			124		pF
Gate resistance	R _g	V _{gs} =0V, V _{ds} =0V, f=1MHz	0.9	1.8	2.7	Ω
SWITCHING PARAMETERS						
Total gate charge (10V)	Q _g	V _{gs} =10V, V _{ds} =15V, I _d =20A		36	49	nC
Total gate charge (4.5V)				17	23	nC
Gate-source charge	Q _{gs}			6		nC
Gate-drain charge	Q _{gd}			8		nC
Turn-on delay time	t _{d(on)}	V _{gs} =10V, V _{ds} =15V R _L =0.75Ω, R _{gen} =3Ω		7.5		ns
Turn-on rise time	t _r			4.0		ns
Turn-off delay time	t _{d(off)}			37.0		ns
Turn-off fall time	t _f			7.5		ns
Body diode reverse recovery time	t _{rr}	I _f =20A, dI/dt=500A/μs		14.0		ns
Body diode reverse recovery charge	Q _{rr}	I _f =20A, dI/dt=500A/μs		20.3		nC

NOTE :

1. The value of R_{θja} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with Ta=25°C. The value in any given application depends on the user's specific board design.
2. The power dissipation Pd is based on T_{j(max)}=150°C, using ≤ 10s junction-to-ambient thermal resistance.
3. Repetitive rating, pulse width limited by junction temperature T_{j(max)}=150°C. Ratings are based on low frequency and duty cycles to keep initial T_j=25°C.
4. The R_{θja} is the sum of the thermal impedance from junction to lead R_{θjal} and lead to ambient.
5. The static characteristics in Figures 1 to 6 are obtained using <300ms pulses, duty cycle 0.5% max.
6. These curves are based on the junction-to-ambient thermal impedance which is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, assuming a maximum junction temperature of T_{j(max)}=150°C. The SOA curve provides a single pulse rating.

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■ Typical electrical and thermal characteristics

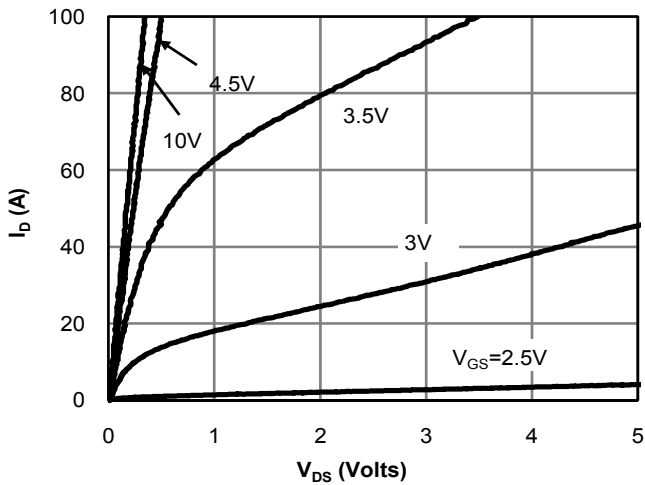


Fig 1: On-Region Characteristics (Note 5)

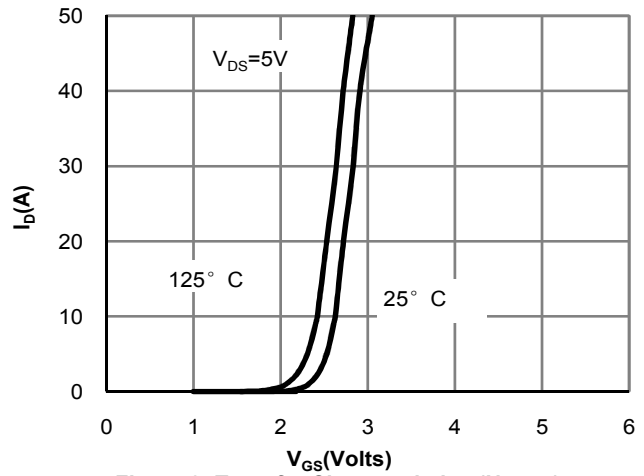


Figure 2: Transfer Characteristics (Note 5)

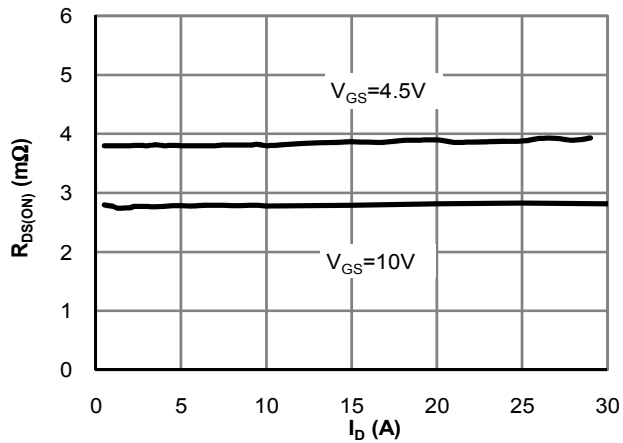


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note 5)

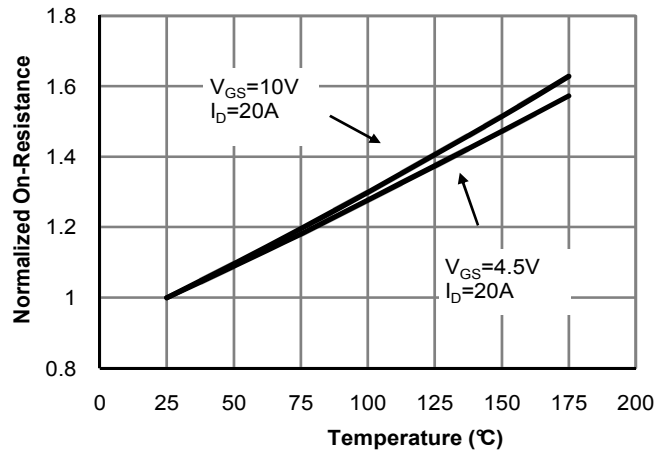


Figure 4: On-Resistance vs. Junction Temperature (Note 5)

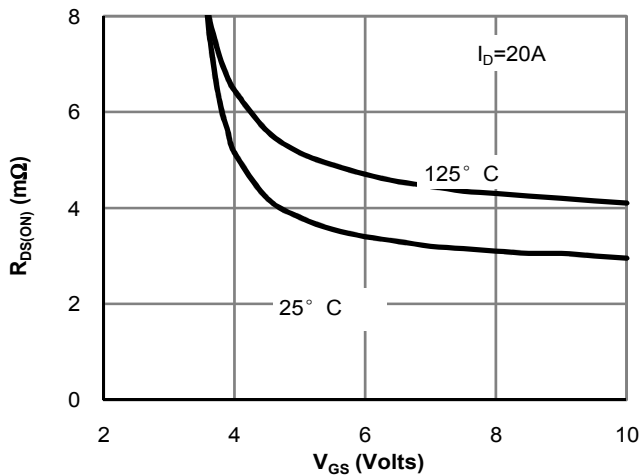


Figure 5: On-Resistance vs. Gate-Source Voltage (Note 5)

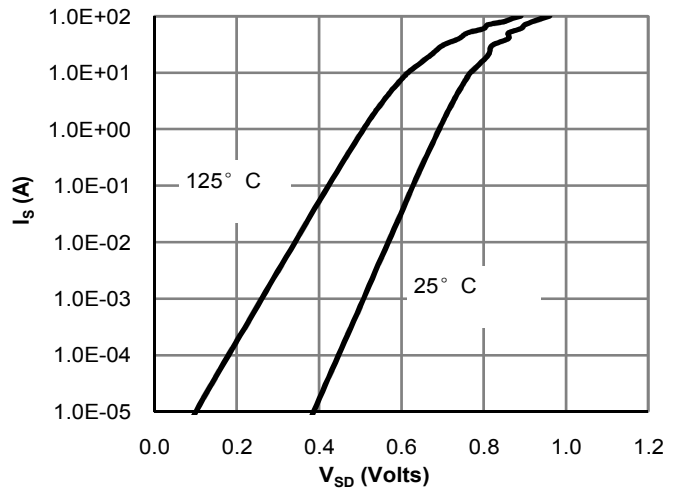


Figure 6: Body-Diode Characteristics (Note 5)

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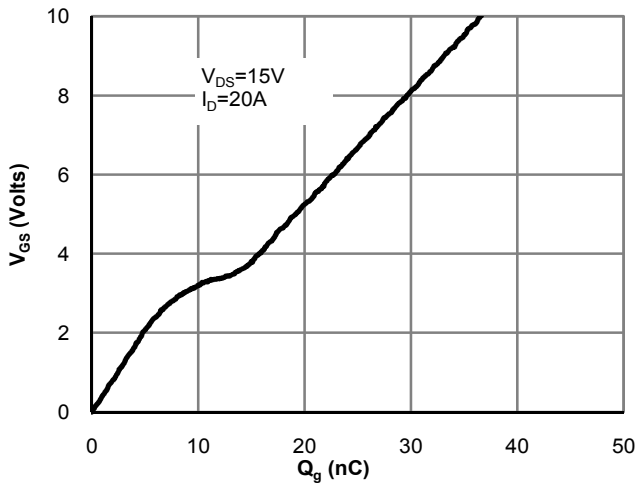


Figure 7: Gate-Charge Characteristics

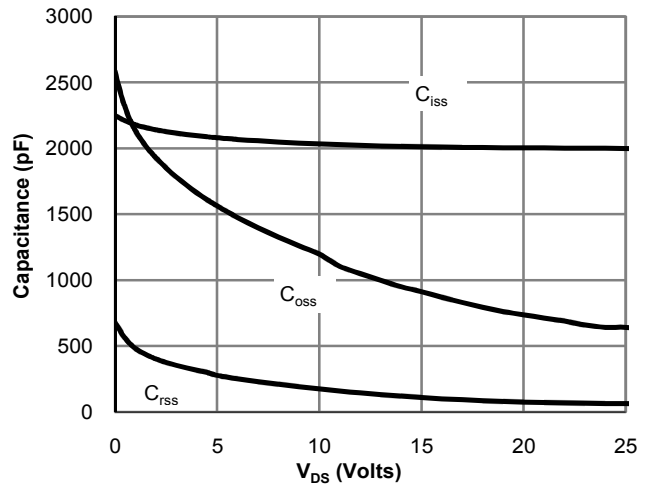


Figure 8: Capacitance Characteristics

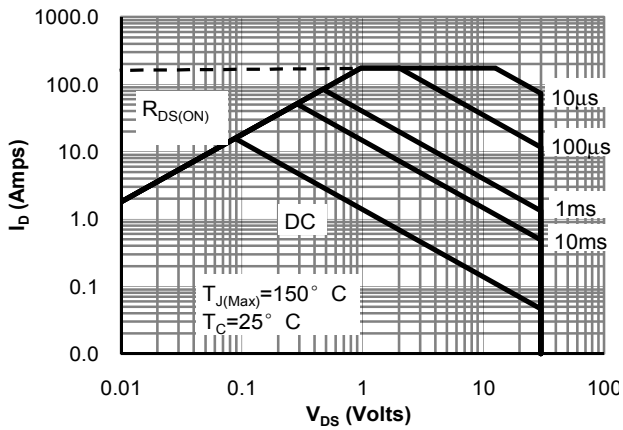


Figure 9: Maximum Forward Biased Safe Operating Area (Note 6)

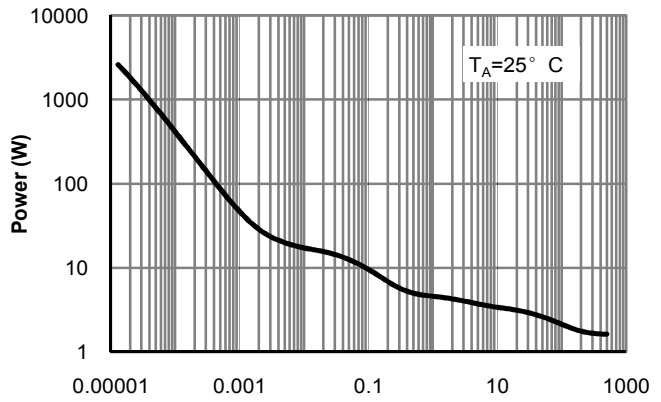


Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note 6)

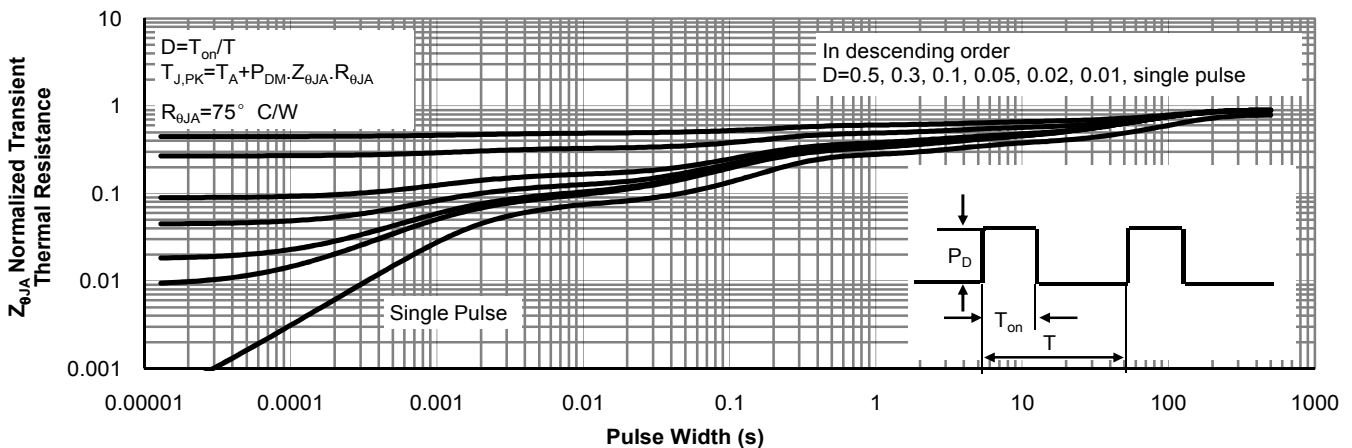


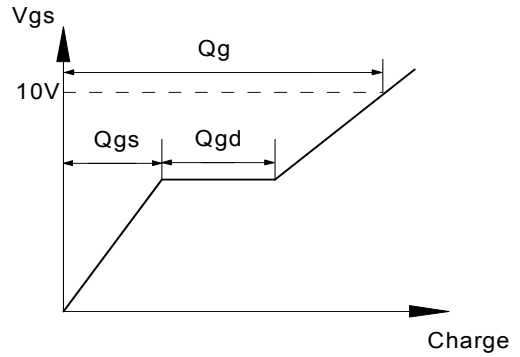
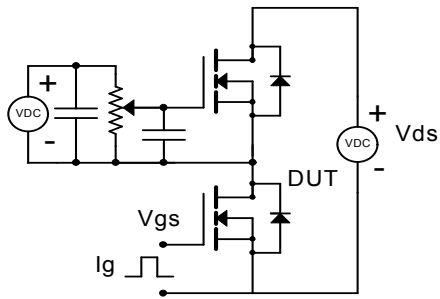
Figure 15: Normalized Maximum Transient Thermal Impedance (Note 6)

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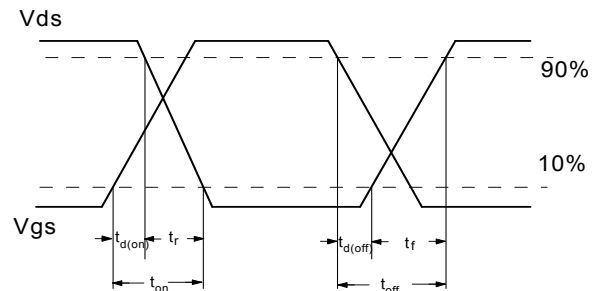
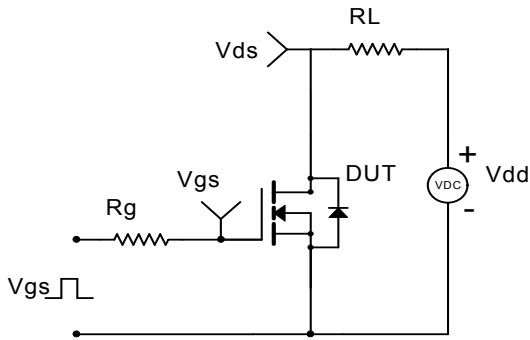
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■ Test circuit and waveform

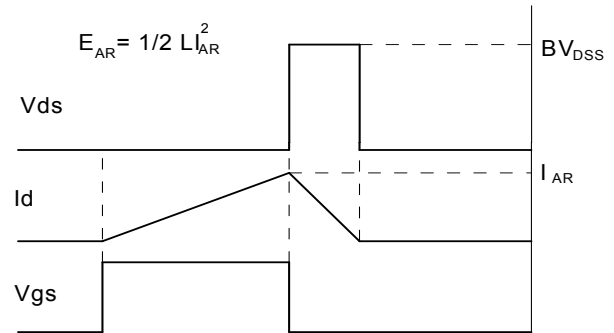
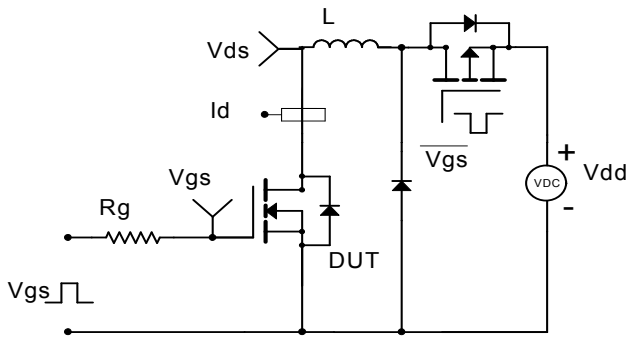
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms

